

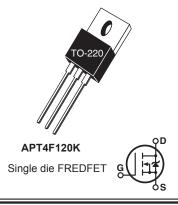


**APT4F120K** 

1200V, 4A, 4.2Ω Max Trr ≤195nS

# N-Channel FREDFET

Power MOS 8<sup>™</sup> is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced trr, soft www.Datafrecovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C<sub>rss</sub>/C<sub>iss</sub> result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



# **FEATURES**

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C<sub>rss</sub> for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant *J*

# **TYPICAL APPLICATIONS**

- · ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

## **Absolute Maximum Ratings**

Symbol	Parameter	Ratings	Unit
	Continuous Drain Current @ T <sub>c</sub> = 25°C	4	
I <sub>D</sub>	Continuous Drain Current @ T <sub>c</sub> = 100°C	3	А
I <sub>DM</sub>	Pulsed Drain Current <sup>①</sup>	15	
V <sub>GS</sub>	Gate - Source Voltage	±30	V
E <sub>AS</sub>	Single Pulse Avalanche Energy <sup>®</sup>	310	mJ
I <sub>AR</sub>	Avalanche Current, Repetitive or Non-Repetitive	2	А

## **Thermal and Mechanical Characteristics**

Symbol	Characteristic		Тур	Мах	Unit	
P <sub>D</sub>	Total Power Dissipation @ $T_c = 25^{\circ}C$		-	225	W	
R <sub>ejc</sub>	Junction to Case Thermal Resistance	-	-	.56	°C/W	
$R_{_{ ext{ heta} ext{ iny CS}}}$	Case to Sink Thermal Resistance, Flat, Greased Surface	-	.11	-		
Τ <sub>J</sub> , Τ <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55	-	150	°C	
Τ <sub>L</sub>	Soldering Temperature for 10 Seconds (1.6mm from case)	-	-	300		
10/	W <sub>T</sub> Package Weight	-	0.07	-	oz	
vv <sub>T</sub>		-	1.22	-	g	
Torque	Mounting Torque (TO-220 Package), 4-40 or M3 screw	-	-	10	in·lbf	
		-	-	1.1	N∙m	

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**Static Characteristics** 

## T<sub>J</sub> = 25°C unless otherwise specified

**APT4F120K** 

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
V <sub>BR(DSS)</sub>	Drain-Source Breakdown Voltage	$V_{_{\rm GS}}$ = 0V, I_{_{\rm D}} = 250µA	1200			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_{D}$ = 250µA		1.41		V/°C
R <sub>DS(on)</sub>	Drain-Source On Resistance ©	V <sub>GS</sub> = 10V, I <sub>D</sub> = 2A		3.42	4.2	Ω
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage		2.5	4	5	V
$\Delta V_{GS(th)} / \Delta T_J$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_{D} = 0.5 \text{mA}$		-10		mV/°C
	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 1200V T <sub>J</sub> = 25°C			250	
DSS		$V_{GS} = 0V$ $T_J = 125^{\circ}C$			1000	μA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			±100	nA

#### **Dynamic Characteristics**

#### T<sub>J</sub> = 25°C unless otherwise specified

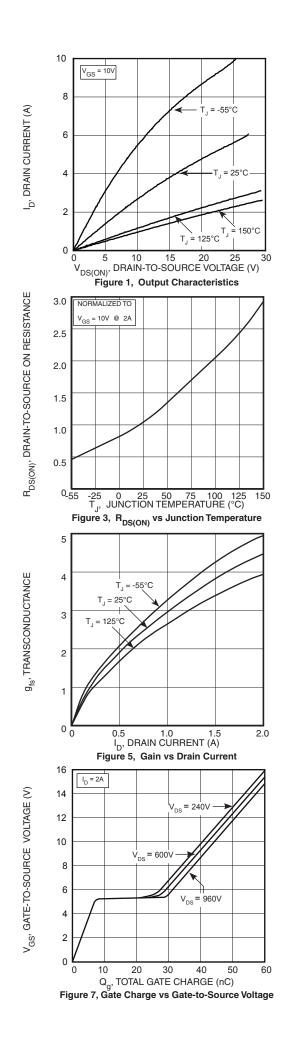
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
9 <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> = 50V, I <sub>D</sub> = 2A		4.5		S
C <sub>iss</sub>	Input Capacitance			1385		
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V f = 1MHz		17		
C <sub>oss</sub>	Output Capacitance			100		рF
C <sub>o(cr)</sub> ④	Effective Output Capacitance, Charge Related	$\lambda = 0 \lambda \lambda = 0 \lambda to 200 \lambda$		40		
C <sub>o(er)</sub> ⑤	Effective Output Capacitance, Energy Related	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 800V$		20		
Q <sub>g</sub>	Total Gate Charge			43		
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 2A,$ $V_{DS} = 600V$		7		nC
Q <sub>gd</sub>	Gate-Drain Charge	V <sub>DS</sub> = 000V		20		
t <sub>d(on)</sub>	Turn-On Delay Time			7.4		
t <sub>r</sub>	Current Rise Time	Resistive Switching		4.4		
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{DD} = 800V, I_{D} = 2A$ $R_{G} = 10\Omega \text{ (6)}, V_{GG} = 15V$		24		ns
t <sub>r</sub>	Current Fall Time	1012 C, V <sub>GG</sub> - 10V		6.9		

## **Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions		Min	Тур	Мах	Unit
۱ <sub>s</sub>	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)	OD D			4	А
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>①</sup>		SU III			15	A
$V_{\rm SD}$	Diode Forward Voltage	$I_{SD} = 2A, T_{J} = 25^{\circ}C, V_{GS} = 0V$			0.8	1.3	V
4	Reverse Recovery Time Reverse Recovery Charge	I <sub>SD</sub> = 2A <sup>③</sup> , di <sub>SD</sub> /dt = 100A/μs, V <sub>DD</sub> = 100V	T <sub>J</sub> = 25°C		170	195	20
t <sub>rr</sub>			T <sub>J</sub> = 125°C		330	400	nS
0			T <sub>J</sub> = 25°C	ĺ	.370		
Q <sub>rr</sub>			T <sub>J</sub> = 125°C		.820		μC
	Reverse Recovery Current		T <sub>J</sub> = 25°C		4.90		
I <sub>rrm</sub>			T <sub>J</sub> = 125°C		5.40		A
dv/dt	Peak Recovery dv/dt	I <sub>SD</sub> ≤2A, di/dt≤1000Aµs, V <sub>DD</sub> = 800V, T <sub>J</sub> =125°C				20	V/ns

Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
Starting at T<sub>J</sub> = 25°C, L = 155.0mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 2A.
Pulse test: Pulse Width < 380µs, duty cycle < 2%.</li>
C<sub>o(cr)</sub> is defined as a fixed capacitance with the same stored charge as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>.
C<sub>o(cr)</sub> is defined as a fixed capacitance with the same stored energy as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>. To calculate C<sub>o(er)</sub> for any value of V<sub>DS</sub> less than V<sub>(BR)DSS</sub>, use this equation: C<sub>o(er)</sub> = -8.32E-8/V<sub>DS</sub><sup>4</sup>2 + 3.49E-8/V<sub>DS</sub> + 1.30E-10.
R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



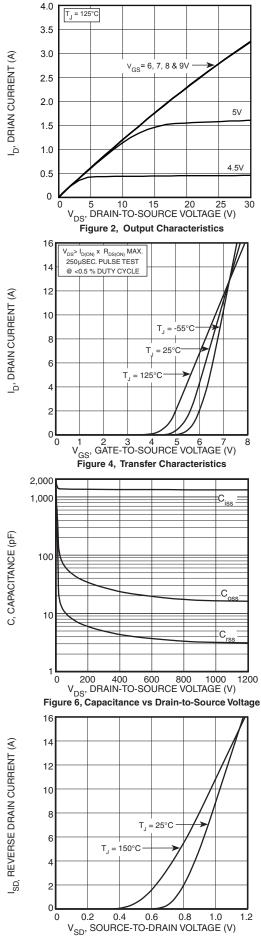
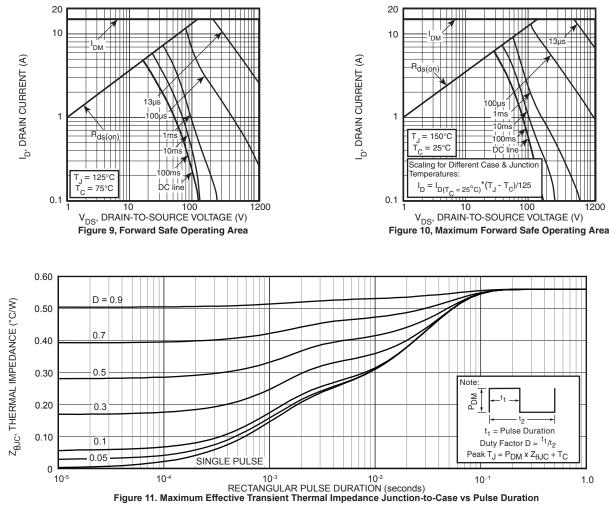


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



#### TO-220 (K) Package Outline e3 100% Sn Plated

10.66 (.420) 9.66 (.380) 1.39 (.055) 0.51 (.020) 5.33 (.210) 4.83 (.190) Drain 6.85<sup>°</sup>(.270) 5.85 (.230) ▲ ٨ 4.08 (.161) Dia. 3.54 (.139) 3.42 (.135) 2.54 (.100) 16.25 (.639) 14.23 (.560) 3.683 (.145) MAX 14.73 (.580) 12.70 (.500) Gate 0.50 (.020) 0.41 (.016) Drain Source 2.92 (.115) 2.04 (.080) 1.01 (.040) 3-Plcs. 0.83 (.033) 1.77 (.070) 3-Plcs. 1.15 (.045) 2.79 (.110) 2.29 (.090) 4.82 (.190) 3.56 (.140) 5.33 (.210) 4.83 (.190)

Dimensions in Millimeters and (Inches)

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